

EMC Test Report

Report No.: AGC05443231011EE01

PRODUCT DESIGNATION Wired type-C earbuds in box

BRAND NAME N/A

MODEL NAME : MO2240

APPLICANT : MID OCEAN BRANDS B.V

DATE OF ISSUE : Oct. 19, 2023

EN 55032:2015/A11:2020 STANDARD(S)

EN 55035:2017/A11:2020

REPORT VERSION V1.0

> Attestation of Globa (Shenzhen) Co., Ltd



Page 2 of 25

REPORT REVISE RECORD

Report Version	Revise Time	Issued Date	Valid Version	Notes	
V1.0	/	Oct. 19, 2023	Valid	Initial release	

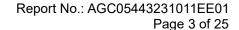
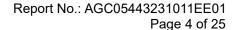




TABLE OF CONTENTS

1. VERIFICATION OF CONFORMITY	4
2. SYSTEM DESCRIPTION	5
3. MEASUREMENT UNCERTAINTY	5
4. PRODUCT INFORMATION	6
5. SUPPORT EQUIPMENT	7
6. TEST FACILITY	8
7. TEST EQUIPMENT LIST	8
8. TESTSUMMARY LIST	9
9. EN 55032 RADIATED EMISSION TEST	10
9.1. LIMITS OF RADIATED DISTURBANCES	10
9.2. BLOCK DIAGRAM OF TEST SETUP	10
9.3. PROCEDURE OF RADIATED EMISSION TEST	11
9.4. TEST RESULT OF RADIATED EMISSION TEST	12
10. EN 61000-4-2 ESD IMMUNITY TEST	14
10.1. BLOCK DIAGRAM OF TEST SETUP	14
10.2. TEST PROCEDURE	16
10.3. PERFORMANCE & RESULT	16
11. EN 61000-4-3 RS IMMUNITY TEST	17
11.1. BLOCK DIAGRAM OF TEST SETUP	17
11.2. TEST PROCEDURE	18
11.3. PERFORMANCE & RESULT	18
APPENDIX A: PHOTOGRAPHS OF TEST SETUP	19
APPENDIX B: PHOTOGRAPHS OF EUT	21





1. VERIFICATION OF CONFORMITY

Applicant	MID OCEAN BRANDS B.V
Address	7/F, Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong
Manufacturer	MID OCEAN BRANDS B.V
Address	7/F, Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong
Factory	MID OCEAN BRANDS B.V
Address	7/F, Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong
Product Designation	Wired type-C earbuds in box
Brand Name	N/A
Test Model	MO2240
Date of receipt of test item	Oct. 12, 2023
Date of test	Oct. 12, 2023 to Oct. 19, 2023
Deviation	No deviation from the test method.
Condition of Test Sample	Normal
Test Result	Pass

The above equipment was tested by Attestation of Global Compliance (Shenzhen) Co., Ltd. for compliance with the requirements set forth in the Technical Standards mentioned above. This said equipment in the configuration described in this report shows the maximum emission levels emanating from equipment and the level of the immunity endurance of the equipment are within the compliance requirements.

The test results of this report relate only to the tested sample identified in this report.

Prepared By	Sty Zhou	
	Sky Zhou (Project Engineer)	Oct. 19, 2023
Reviewed By	Calin Lin	
	Calvin Liu (Reviewer)	Oct. 19, 2023
Approved By	Max Zhang	
	Max Zhang (Authorized Officer)	Oct. 19, 2023



Page 5 of 25

2. SYSTEM DESCRIPTION

	TEST MODE DESCRIPTION					
NO.	TEST MODE DESCRIPTION					
1	Audio playing(Connect mobile phone)					

3. MEASUREMENT UNCERTAINTY

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in measurement" (GUM) published by ISO.

- Uncertainty of Conducted Emission, Uc = ±2.9 dB
- Uncertainty of Radiated Emission (Below 1G), Uc = ±3.9 dB
- Uncertainty of Radiated Emission above 1GHz, Uc = ±4.9dB



Page 6 of 25

4. PRODUCT INFORMATION

Housing Type	Plastic and holsters
Hardware Version	N/A
Software Version	N/A
Power Supply	DC 5V by mobile phone

I/O Port Information (⊠ Applicable ☐ Not Applicable)

I/O Port of EUT						
I/O Port Type Number Cable Description Tested With						
AUX IN	1	115cm	1			



Page 7 of 25

5. SUPPORT EQUIPMENT

Device Type	Manufacturer	Model Name	Serial No.	Data Cable	Power Cable
Xiaomi Phone	Xiaomi	MI 10			

Note: All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.



Page 8 of 25

6. TEST FACILITY

Site	Attestation of Global Compliance (Shenzhen) Co., Ltd
Location	1-2/F, Building 19, Junfeng Industrial Park, Chongqing Road, Heping Community, Fuhai Street, Bao 'an District, Shenzhen, Guangdong, China

7. TEST EQUIPMENT LIST

TEST EQUIPMENT OF RADIATED EMISSION TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Test Receiver	R&S	ESCI	10096	Feb. 18, 2023	Feb. 17, 2024
Antenna	SCHWARZBECK	VULB9168	494	Jan. 05, 2023	Jan. 04, 2025
Test software	FARA	EZ-EMC(Ver.RA-03A)	N/A	N/A	N/A

TEST EQUIPMENT OF ESD TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
ESD Simulator	Schaffner	NSG 438	782	Dec. 30, 2022	Dec. 29, 2023

TEST EQUIPMENT OF RS IMMUNITY TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Signal Generator	Aglient	N5182A	MY50140530	Feb. 17, 2023	Feb. 16, 2024
Directional coupler	Werlatone	C5571-10	99463	Mar. 10, 2022	Mar. 09, 2024
Directional coupler	Werlatone	C5571-10	99482	Mar. 10, 2022	Mar. 09, 2024
Power Meter	R&S	NRVD	8323781027	Mar. 24, 2022	Mar. 23, 2025
Power Amplifier	KALMUS	7100LC	04-02/17-06-001	N/A	N/A
Biconilog Antenna	ETS	3142C	00060447	N/A	N/A
Test Software	Tonscend	2.0.1.8	N/A	N/A	N/A



Page 9 of 25

8. TESTSUMMARY LIST

Test item	Test Requirement	Test Method	Class/Severity	Result
Conducted emission	EN 55032	EN 55032	Class B	N/A
Radiated emission	EN 55032	EN 55032	Class B	Pass
Harmonic current emission	EN IEC 61000-3-2	EN IEC 61000-3-2	Class A	N/A
Voltage fluctuations & flicker	EN 61000-3-3	EN 61000-3-3	§5 of EN 61000-3-3	N/A
Electrostatic discharge immunity	EN 55035	EN 61000-4-2	± 8.0 kV (Air Discharge) ± 4.0 kV (Contact Discharge) ± 4.0 kV (Indirect Discharge)	Pass
Radiated electromagnetic field immunity	EN 55035	EN 61000-4-3	3V/m with 80% AM. 1kHz Modulation.	Pass
Electrical fast transient/burst Immunity	EN 55035	EN 61000-4-4	+/- 1kV for Power Supply Lines	N/A
Surge immunity	EN 55035	EN 61000-4-5	+/- 1kV (Line to Line) +/- 2kV (Line to Ground)	N/A
Immunity to Conducted Disturbances Induced by RF fields	EN 55035	EN 61000-4-6	3V(0.15MHz-10MHz) 3V-1V(10MHz-30MHz) 1V(30MHz-80MHz) with 80% AM. 1 kHz Modulation	N/A
Power frequency magnetic field	EN 55035	EN 61000-4-8	1A/m 50Hz or 60Hz	N/A
Voltage dips and short interruptions immunity	EN 55035	EN 61000-4-11	0degrees	N/A

Note: N/A means not applicable.



9. EN 55032 RADIATED EMISSION TEST

9.1. LIMITS OF RADIATED DISTURBANCES

Limits for radiated disturbance 30M to1 GHz at a measurement distance of 3 m

Frequency range (MHz)	Quasi peak limits(dBuV/m), for Class B ITE, at 3m measurement distance
30 - 230	40
230 - 1000	47

Limits for radiated disturbance above 1 GHz at a measurement distance of 3 m

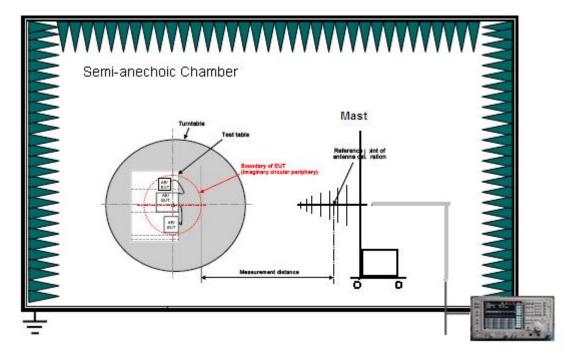
Eroqueney rongo (MUT)	Limits (dBu\	//m), Class B ITE
Frequency range (MHz)	Peak	Average
1000-3000	70	50
3000-6000	74	54

Notes:

- 1. The lower limit shall apply at the transition frequency.
- 2. Additional provisions may be required for cases where interference occurs.

9.2. BLOCK DIAGRAM OF TEST SETUP

System Diagram of Connections between EUT and Simulators





Report No.: AGC05443231011EE01 Page 11 of 25

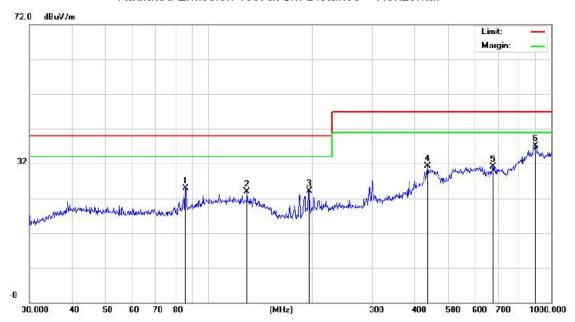
9.3. PROCEDURE OF RADIATED EMISSION TEST

- (1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane as per EN 55032 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 10cm non-conductive covering to insulate the EUT from the ground plane.
- (2) Support equipment, if needed, was placed as per EN 55032.
- (3) All I/O cables were positioned to simulate typical actual usage as per EN 55032.
- (4) The EUT connected mobile phone for normal operation.
- (5) The antenna was placed at 3 meter away from the EUT as stated in EN 55032. The antenna connected to the Analyzer via a cable and at times a pre-amplifier would be used.
- (6) The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- (7) The test mode(s) were scanned during the test:
- (8) Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and Q.P./Peak reading is presented.



9.4. TEST RESULT OF RADIATED EMISSION TEST

Radiated Emission Test at 3m Distance – Horizontal

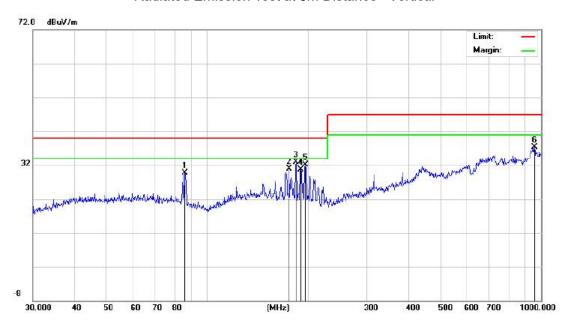


No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
1		85.5977	11.03	13.97	25.00	40.00	-15.00	peak
2		129.4677	8.04	15.83	23.87	40.00	-16.13	peak
3		197.2001	9.97	14.18	24.15	40.00	-15.85	peak
4		435.5898	7.09	24.15	31.24	47.00	-15.76	peak
5		675.2080	6.68	24.41	31.09	47.00	-15.91	peak
6	*	900.1474	5.32	31.78	37.10	47.00	-9.90	peak

RESULT: PASS



Radiated Emission Test at 3m Distance -Vertical



No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
1		85.5977	13.53	16.14	29.67	40.00	-10.33	peak
2		176.2685	12.49	18.44	30.93	40.00	-9.07	peak
3	*	184.4898	14.50	18.37	32.87	40.00	-7.13	peak
4		190.4050	12.61	18.19	30.80	40.00	-9.20	peak
5		196.5098	14.05	18.00	32.05	40.00	-7.95	peak
6		955.4380	6.96	30.38	37.34	47.00	-9.66	peak

RESULT: PASS

Note:

Level(dBuV/m)=Reading(dBuV)+Factor(dB/m)

Factor(dB/m)=Antenna Factor(dB/m)+Cable loss(dB)+Attenuation(dB)for Attenuator

Over= Measurement- Limit



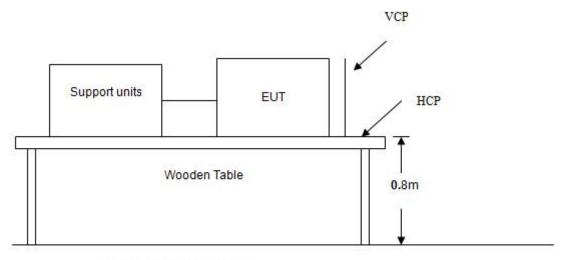
10. EN 61000-4-2 ESD IMMUNITY TEST

ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

Port	Enclosure	
Basic Standard	EN 61000-4-2	
Test Level	± 8.0 kV (Air Discharge) ± 4.0 kV (Contact Discharge) ± 4.0 kV (Indirect Discharge)	
Standard require	В	
Temperature 23°C		
Humidity	lumidity 42% RH	

10.1. BLOCK DIAGRAM OF TEST SETUP

(The 470 k ohm resistors are installed per standard requirement)



Ground Reference Plane₽



Page 15 of 25

ESD LOCATION:

Blue line: Air discharge Red line: Contact discharge





Report No.: AGC05443231011EE01 Page 16 of 25

10.2. TEST PROCEDURE

The test procedure shall be in accordance with EN 61000-4-2. Electrostatic discharges shall be applied only to points and surfaces of the EUT which are expected to be touched during normal operation, including user access operations specified in the user manual, for example cleaning or adding consumables when the EUT is powered. The application of discharges to the contacts of open connectors is not required.

The number of test points is EUT dependent. Sub clause 8.3.1 and Clause A.5 of EN 61000-4-2 shall be taken into consideration when selecting test points, paying particular attention to keyboards, dialling pads, power switches, mice, drive slots, card slots, the areas around communication ports, etc.

When applying direct discharges to a portable or handheld battery-powered EUT with a display screen, it may not be possible to observe the screen for a given EUT orientation. If observation of the screen is necessary during this test, the EUT may be mounted vertically using non-metallic supports.

Note: As per the A2 to EN 61000-4-2, a bleed resistor cable is connected between the EUT and HCP during the test. The electrostatic discharges were applied as follows:

Voltage	Coupling	Test Performance	Result
±4kV	Contact Discharge	No function loss	A
±4kV	Indirect Discharge HCP (Front)	No function loss	Α
±4kV	Indirect Discharge HCP (Left)	No function loss	A
±4kV	Indirect Discharge HCP (Back)	No function loss	A
±4kV	Indirect Discharge HCP (Right)	No function loss	A
±4kV	Indirect Discharge VCP (Front)	No function loss	A
±4kV	Indirect Discharge VCP (Left)	No function loss	A
±4kV	Indirect Discharge VCP (Back)	No function loss	Α
±4kV	Indirect Discharge VCP (Right)	No function loss	Α
±8kV	Air Discharge	No function loss	Α

10.3. PERFORMANCE & RESULT

10.5. F LINI OIN	WANCE & RESULT
Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

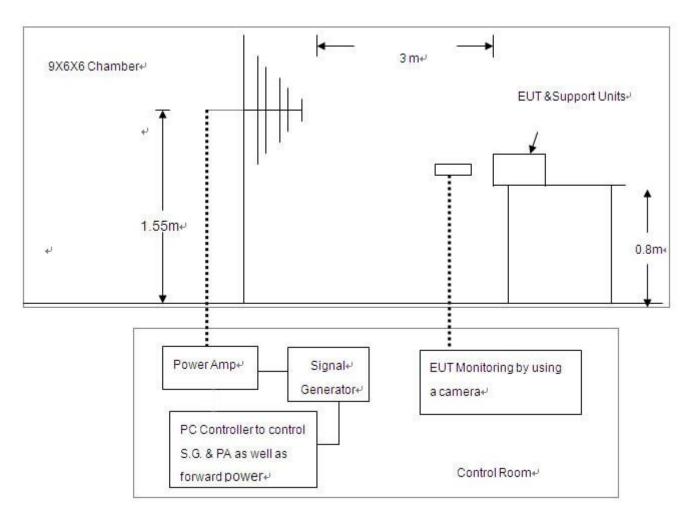


11. EN 61000-4-3 RS IMMUNITY TEST

RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port	Enclosure			
Basic Standard	EN 61000-4-3			
Test Level:	3V/m with 80% AM. 1kHz Modulation.			
Standard require	A			
Temperature 23.4°C				
Humidity 61.9% RH				

11.1. BLOCK DIAGRAM OF TEST SETUP





Page 18 of 25

11.2. TEST PROCEDURE

The EUT was located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity. The support units were located outside of the uniformity area, but the cable(s) connected with EUT were exposed to the calibrated field as per EN 61000-4-3.

EUT worked with resistance load, and make sure EUT worked normally.

Setting the testing parameters of RS test software per EN 61000-4-3.

Performing the test at each side of with specified level (3V/m) at 1% steps and test frequency from 80MHz to 1000MHz

Recording the test result in following table.

EN 61000-4-3 Final test conditions:

Test level: 3V/m

Steps: 1 % of fundamental

Dwell Time: 1 sec

Range (MHz)	Field	Modulation	Polarity	Position	Test Performance	Result
80-1000	3V/m	AM	H/V	Front	No function loss	А
80-1000	3V/m	AM	H/V	Left	No function loss A	
80-1000	3V/m	AM	H/V	Back	No function loss A	
80-1000	3V/m	AM	H/V	Right	No function loss	А
1800,2600, 3500,5000	3V/m	AM	H/V	Front	No function loss	А
1800,2600, 3500,5000	3V/m	AM	H/V	Left	No function loss	А
1800,2600, 3500,5000	3V/m	AM	H/V	Back	No function loss	А
1800,2600, 3500,5000	3V/m	AM	H/V	Right	No function loss	А

Frequency (±1 %) for Spot test.

11.3. PERFORMANCE & RESULT

Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

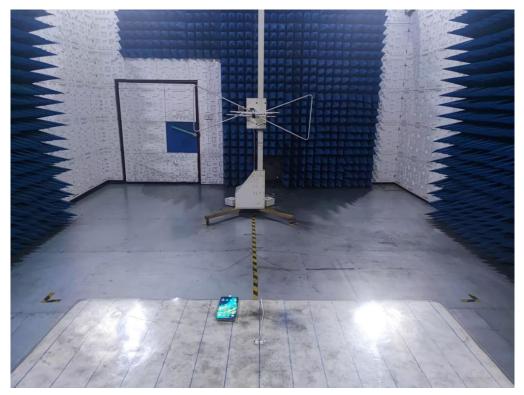
\boxtimes PASS	
------------------	--

Stamp" is deemed to be invalid. Copying or excerpting portion of, or altering the content of the report is not permitted without the written authorization of AGC. The test results presented in the report apply only to the tested sample. Any objections to report issued by AGC should be submitted to AGC within 15days after the issuance of the test report. Further enquiry of validity or verification of the test report should be addressed to AGC by agc01@agccert.com.

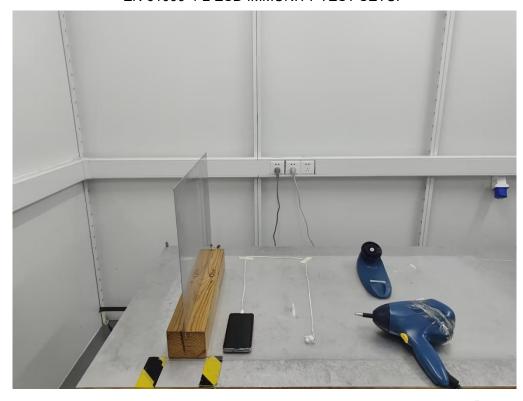


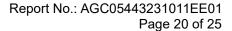
APPENDIX A: PHOTOGRAPHS OF TEST SETUP

EN 55032 RADIATED EMISSION TEST SETUP



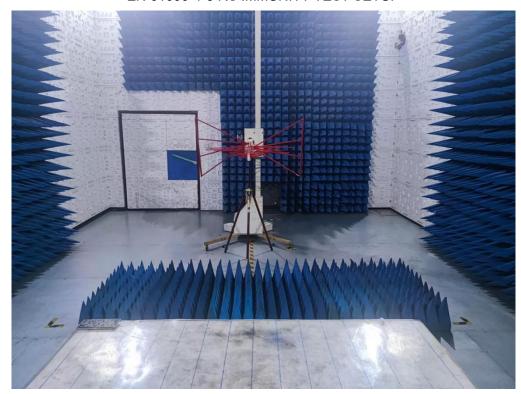
EN 61000-4-2 ESD IMMUNITY TEST SETUP

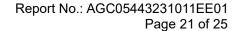






EN 61000-4-3 RS IMMUNITY TEST SETUP





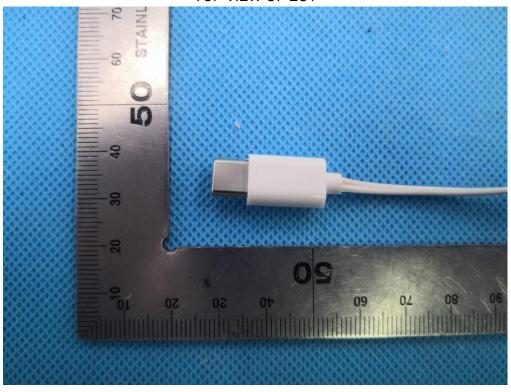


APPENDIX B: PHOTOGRAPHS OF EUT

All VIEW OF EUT



TOP VIEW OF EUT

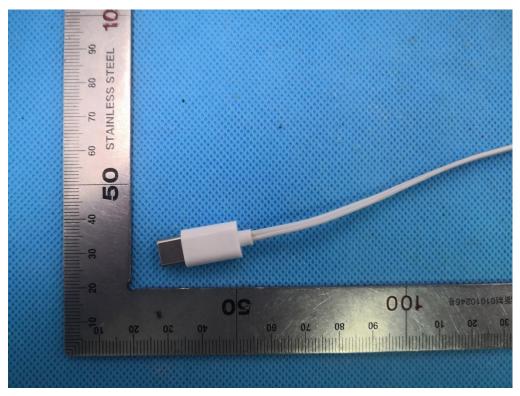


Any report having not been signed by authorized approver, or having been altered without authorization, or having not been stamped by the "Dedicated Testing/Inspection Stamp" is deemed to be invalid. Copying or excerpting portion of, or altering the content of the report is not permitted without the written authorization of AGC. The test results presented in the report apply only to the tested sample. Any objections to report issued by AGC should be submitted to AGC within 15days after the issuance of the test report. Further enquiry of validity or verification of the test report should be addressed to AGC by agc01@agccert.com.

Tel: +86-755 2523 4088 E-mail: agc@agccert.com Web: http://www.agccert.com/



BOTTOM VIEW OF EUT

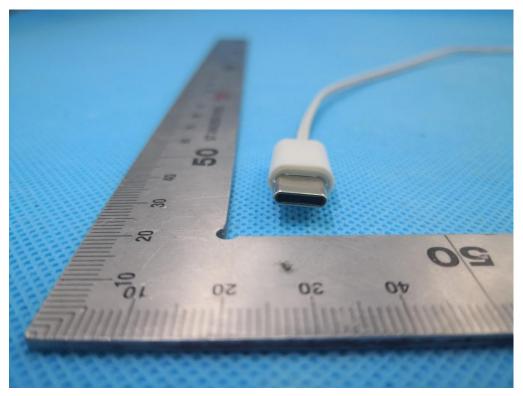


FRONT VIEW OF EUT

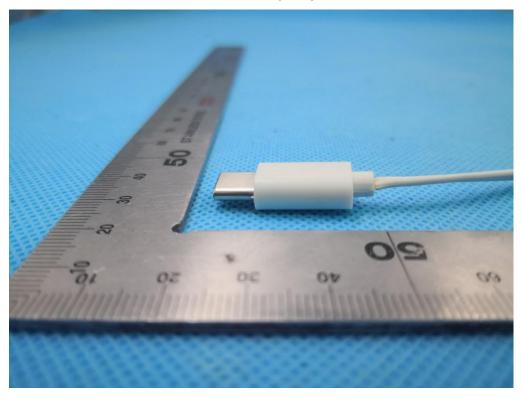




BACK VIEW OF EUT

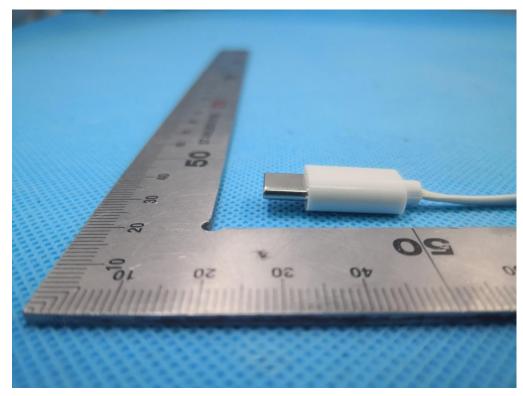


LEFT VIEW OF EUT

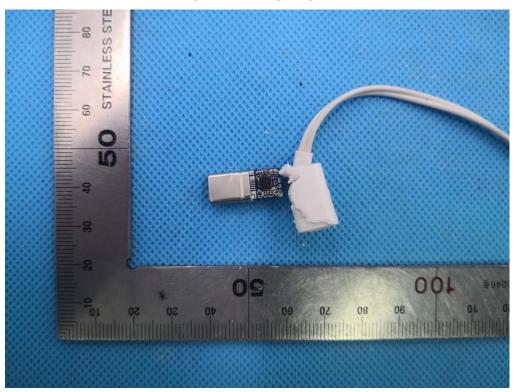




RIGHT VIEW OF EUT

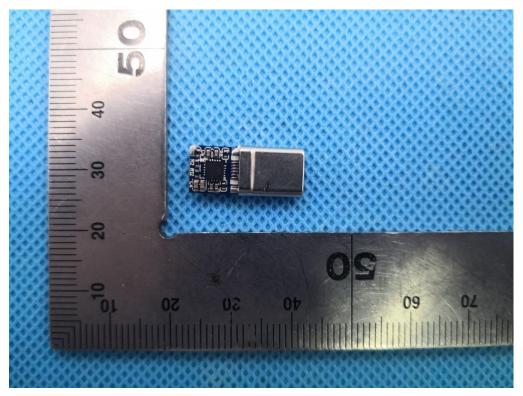


OPEN VIEW OF EUT

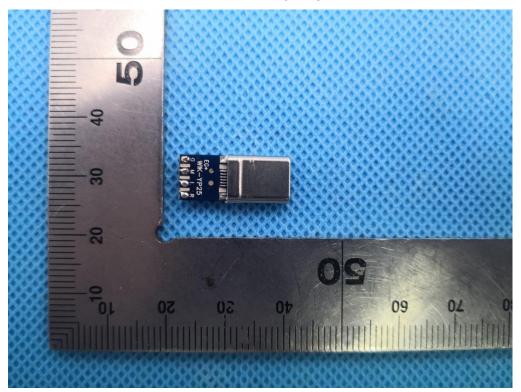




INTEMAL VIEW OF EUT-1



INTEMAL VIEW OF EUT-2



----END OF REPORT-----



Conditions of Issuance of Test Reports

- 1. All samples and goods are accepted by the Attestation of Global Compliance (Shenzhen) Co., Ltd (the "Company") solely for testing and reporting in accordance with the following terms and conditions. The company provides its services on the basis that such terms and conditions constitute express agreement between the company and any person, firm or company requesting its services (the "Clients").
- 2. Any report issued by Company as a result of this application for testing services (the "Report") shall be issued in confidence to the Clients and the Report will be strictly treated as such by the Company. It may not be reproduced either in its entirety or in part and it may not be used for advertising or other unauthorized purposes without the written consent of the Company. The Clients to whom the Report is issued may, however, show or send it, or a certified copy thereof prepared by the Company to its customer, supplier or other persons directly concerned. The Company will not, without the consent of the Clients, enter into any discussion or correspondence with any third party concerning the contents of the Report, unless required by the relevant governmental authorities, laws or court orders.
- 3. The Company shall not be called or be liable to be called to give evidence or testimony on the Report in a court of law without its prior written consent, unless required by the relevant governmental authorities, laws or court orders.
- 4. In the event of the improper use of the report as determined by the Company, the Company reserves the right to withdraw it, and to adopt any other additional remedies which may be appropriate.
- 5. Samples submitted for testing are accepted on the understanding that the Report issued cannot form the basis of, or be the instrument for, any legal action against the Company.
- 6. The Company will not be liable for or accept responsibility for any loss or damage however arising from the use of information contained in any of its Reports or in any communication whatsoever about its said tests or investigations.
- 7.Clients wishing to use the Report in court proceedings or arbitration shall inform the Company to that effect prior to submitting the sample for testing.
- 8. The Company is not responsible for recalling the electronic version of the original report when any revision is made to them. The Client assumes the responsibility to providing the revised version to any interested party who uses them.
- 9. Subject to the variable length of retention time for test data and report stored hereinto as otherwise specifically required by individual accreditation authorities, the Company will only keep the supporting test data and information of the test report for a period of six years. The data and information will be disposed of after the aforementioned retention period has elapsed. Under no circumstances shall we provide any data and information which has been disposed of after retention period. Under no circumstances shall we be liable for damage of any kind, including (but not limited to) compensatory damages, lost profits, lost data, or any form of special, incidental, indirect, consequential or punitive damages of any kind, whether based on breach of contract of warranty, tort (including negligence), product liability or otherwise, even if we are informed in advance of the possibility of such damages.